

BLC8G27LS-180AV

Power LDMOS transistor

Rev. 2 — 9 February 2015

Product data sheet

1. Product profile

1.1 General description

180 W LDMOS packaged asymmetrical Doherty power transistor for base station applications at frequencies from 2496 MHz to 2690 MHz.

Table 1. Typical performance

Typical RF performance at $T_{case} = 25\text{ }^{\circ}\text{C}$ in a Doherty production test circuit.

Test signal	f	V _{DS}	P _{L(AV)}	G _p	η_D	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)
1-carrier W-CDMA	2496 to 2690	28	28	14	43.5	-30 [1]

[1] Test signal: 3GPP test model 1; 1 to 64 DPCH; PAR = 7.2 dB at 0.01 % probability on CCDF.

1.2 Features and benefits

- High efficiency
- Excellent ruggedness
- Designed for broadband operation
- Low thermal resistance providing excellent thermal stability
- Integrated ESD protection
- Designed for low memory effects providing excellent pre-distortability
- Lower output capacitance for improved performance in Doherty applications
- Asymmetrical design to achieve optimal efficiency across the band
- Decoupling leads to enable improved video bandwidth
- Internally matched for ease of use (input and output)
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

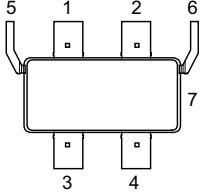
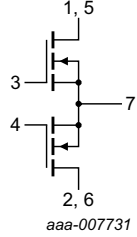
1.3 Applications

- RF power amplifier for W-CDMA base stations and multi carrier applications in the 2496 MHz to 2690 MHz frequency range



2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	drain1 (main)		
2	drain2 (peak)		
3	gate1 (main)		
4	gate2 (peak)		
5	video decoupling (main)		
6	video decoupling (peak)		
7	source ^[1]		

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BLC8G27LS-180AV	-	air cavity plastic earless flanged package; 6 leads	SOT1275-3

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	65	V
V_{GS}	gate-source voltage		-0.5	+13	V
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature ^[1]		-	225	°C

[1] Continuous use at maximum temperature will affect the reliability, for details refer to the on-line MTF calculator.

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-case)}$	thermal resistance from junction to case	$T_{case} = 80\text{ °C}$; $V_{DS} = 28\text{ V}$; $I_{Dq} = 200\text{ mA}$; $V_{GS(amp)peak} = 0.6\text{ V}$; $f = 2600\text{ MHz}$; $P_L = 28\text{ W}$	0.38	K/W

6. Characteristics

Table 6. DC characteristics

$T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Main device						
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0\text{ V}; I_D = 0.7\text{ mA}$	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10\text{ V}; I_D = 72\text{ mA}$	1.5	1.9	2.3	V
V_{GSq}	gate-source quiescent voltage	$V_{DS} = 28\text{ V}; I_D = 300\text{ mA}$	1.6	2.0	2.4	V
I_{DSS}	drain leakage current	$V_{GS} = 0\text{ V}; V_{DS} = 28\text{ V}$	-	-	1.2	μA
I_{DSX}	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75\text{ V}; V_{DS} = 10\text{ V}$	-	13.3	-	A
I_{GSS}	gate leakage current	$V_{GS} = 11\text{ V}; V_{DS} = 0\text{ V}$	-	-	120	nA
g_{fs}	forward transconductance	$V_{DS} = 10\text{ V}; I_D = 72\text{ mA}$	-	0.63	-	S
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75\text{ V}; I_D = 2.52\text{ A}$	-	198	318	$\text{m}\Omega$
Peak device						
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0\text{ V}; I_D = 1.3\text{ mA}$	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10\text{ V}; I_D = 130\text{ mA}$	1.5	1.9	2.3	V
V_{GSq}	gate-source quiescent voltage	$V_{DS} = 28\text{ V}; I_D = 600\text{ mA}$	1.6	2.0	2.4	V
I_{DSS}	drain leakage current	$V_{GS} = 0\text{ V}; V_{DS} = 28\text{ V}$	-	-	1.2	μA
I_{DSX}	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75\text{ V}; V_{DS} = 10\text{ V}$	-	23	-	A
I_{GSS}	gate leakage current	$V_{GS} = 11\text{ V}; V_{DS} = 0\text{ V}$	-	-	120	nA
g_{fs}	forward transconductance	$V_{DS} = 10\text{ V}; I_D = 130\text{ mA}$	-	1.13	-	S
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75\text{ V}; I_D = 4.55\text{ A}$	-	109	155	$\text{m}\Omega$

Table 7. RF characteristics

Test signal: 1-carrier W-CDMA; PAR = 7.2 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1 to 64 DPCH; $f_1 = 2496\text{ MHz}$; $f_2 = 2690\text{ MHz}$; RF performance at $V_{DS} = 28\text{ V}$; $I_{Dq} = 200\text{ mA}$ (main); $V_{GS(amp)peak} = 0.6\text{ V}$; $T_{case} = 25\text{ }^{\circ}\text{C}$; unless otherwise specified; in an asymmetrical Doherty production test circuit at 2496 MHz to 2690 MHz.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
G_p	power gain	$P_{L(AV)} = 28\text{ W}$	13	14	-	dB
RL_{in}	input return loss	$P_{L(AV)} = 28\text{ W}$	-	-10	-7	dB
η_D	drain efficiency	$P_{L(AV)} = 28\text{ W}$	39.5	43.5	-	%
ACPR	adjacent channel power ratio	$P_{L(AV)} = 28\text{ W}$	-	-30	-26	dBc

Table 8. RF characteristics

Test signal: pulsed CW; $t_p = 100\text{ }\mu\text{s}$; $\delta = 10\text{ %}$; $f = 2690\text{ MHz}$; RF performance at $V_{DS} = 28\text{ V}$; $I_{Dq} = 200\text{ mA}$ (main); $V_{GS(amp)peak} = 0.6\text{ V}$; $T_{case} = 25\text{ }^{\circ}\text{C}$; unless otherwise specified; in an asymmetrical Doherty production test circuit at 2496 MHz to 2690 MHz.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$P_{L(3dB)}$	output power at 3 dB gain compression		153	173	193	W

7. Test information

7.1 Ruggedness in Doherty operation

The BLC8G27LS-180AV is capable of withstanding a load mismatch corresponding to a VSWR = 10 : 1 through all phases under the following conditions: $V_{DS} = 28$ V; $I_{DQ} = 200$ mA (main); $V_{GS(amp)peak} = 0.6$ V; $P_L = 140$ W; $f = 2496$ MHz.

7.2 Impedance information

Table 9. Typical impedance of main device

Measured load-pull data of main device; $I_{DQ} = 420$ mA (main); $V_{DS} = 28$ V.

f (MHz)	Z_S [1] (Ω)	Z_L [1] (Ω)	P_L [2] (W)	η_D [2] (%)	G_p [2] (dB)
Maximum power load					
2496	3.1 – j7.4	2.7 – j7.7	49.4	56.4	14.7
2600	4.0 – j7.7	2.7 – j8.3	49.3	54.8	15.3
2690	4.6 – j7.2	2.7 – j8.3	49.4	56	16.1
Maximum drain efficiency load					
2496	3.1 – j7.4	5.7 – j6.1	47.7	63.3	17
2600	4.0 – j7.7	4.2 – j6.1	48.1	62.6	17.5
2690	4.6 – j7.2	3.7 – j6.4	48.2	63	18.2

[1] Z_S and Z_L defined in [Figure 1](#).

[2] at 3 dB gain compression.

Table 10. Typical impedance of peak device

Measured load-pull data of peak device; $I_{DQ} = 780$ mA (peak); $V_{DS} = 28$ V.

f (MHz)	Z_S [1] (Ω)	Z_L [1] (Ω)	P_L [2] (W)	η_D [2] (%)	G_p [2] (dB)
Maximum power load					
2496	3.9 – j8.9	3.9 – j10.8	51.7	55	14.2
2600	5.3 – j9.3	4.7 – j12.0	51.6	52.4	14.6
2690	6.3 – j7.6	6.0 – j12.4	51.3	54	15.6
Maximum drain efficiency load					
2496	3.9 – j8.9	3.9 – j7.6	50.2	62.5	16.3
2600	5.3 – j9.3	3.3 – j8.3	49.9	61.6	17
2690	6.3 – j7.6	4.1 – j9.1	49.8	60.5	17.6

[1] Z_S and Z_L defined in [Figure 1](#).

[2] at 3 dB gain compression.

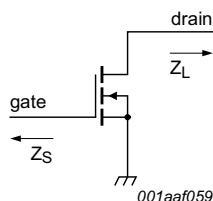


Fig 1. Definition of transistor impedance

7.3 Recommended impedances for Doherty design

Table 11. Typical impedance of main device at 1 : 1 load

Measured load-pull data of main device; $I_{DQ} = 420$ mA (main); $V_{DS} = 28$ V.

f	Z_S [1]	Z_L [1]	P_L [2]	η_D [3]	G_p [3]
(MHz)	(Ω)	(Ω)	(dBm)	(%)	(dB)
2496	3.9 – j8.9	4.0 – j7.6	49.0	42	18.8
2600	5.3 – j9.3	3.9 – j7.5	48.9	41	19.0
2690	6.3 – j7.6	3.3 – j7.6	49.1	40	20.0

[1] Z_S and Z_L defined in Figure 1.

[2] at 3 dB gain compression.

[3] at $P_{L(AV)} = 44.5$ dBm.

Table 12. Typical impedance of main device at 1 : 2 load

Measured load-pull data of main device; $I_{DQ} = 420$ mA (main); $V_{DS} = 28$ V.

f	Z_S [1]	Z_L [1]	P_L [2]	η_D [3]	G_p [3]
(MHz)	(Ω)	(Ω)	(dBm)	(%)	(dB)
2496	3.9 – j8.9	7.7 – j5.8	46.7	53.0	20.5
2600	5.3 – j9.3	7.0 – j5.1	46.5	52.0	21.0
2690	6.3 – j7.6	5.4 – j5.5	47.0	51.0	22.0

[1] Z_S and Z_L defined in Figure 1.

[2] at 3 dB gain compression.

[3] at $P_{L(AV)} = 44.5$ dBm.

7.4 VBW in Doherty operation

The BLC8G27LS-180AV shows 125 MHz (typical) video bandwidth in Doherty development board in 2600 MHz at $V_{DS} = 28$ V; $I_{DQ} = 200$ mA and $V_{GS(amp)peak} = 0.6$ V.

7.5 Test circuit

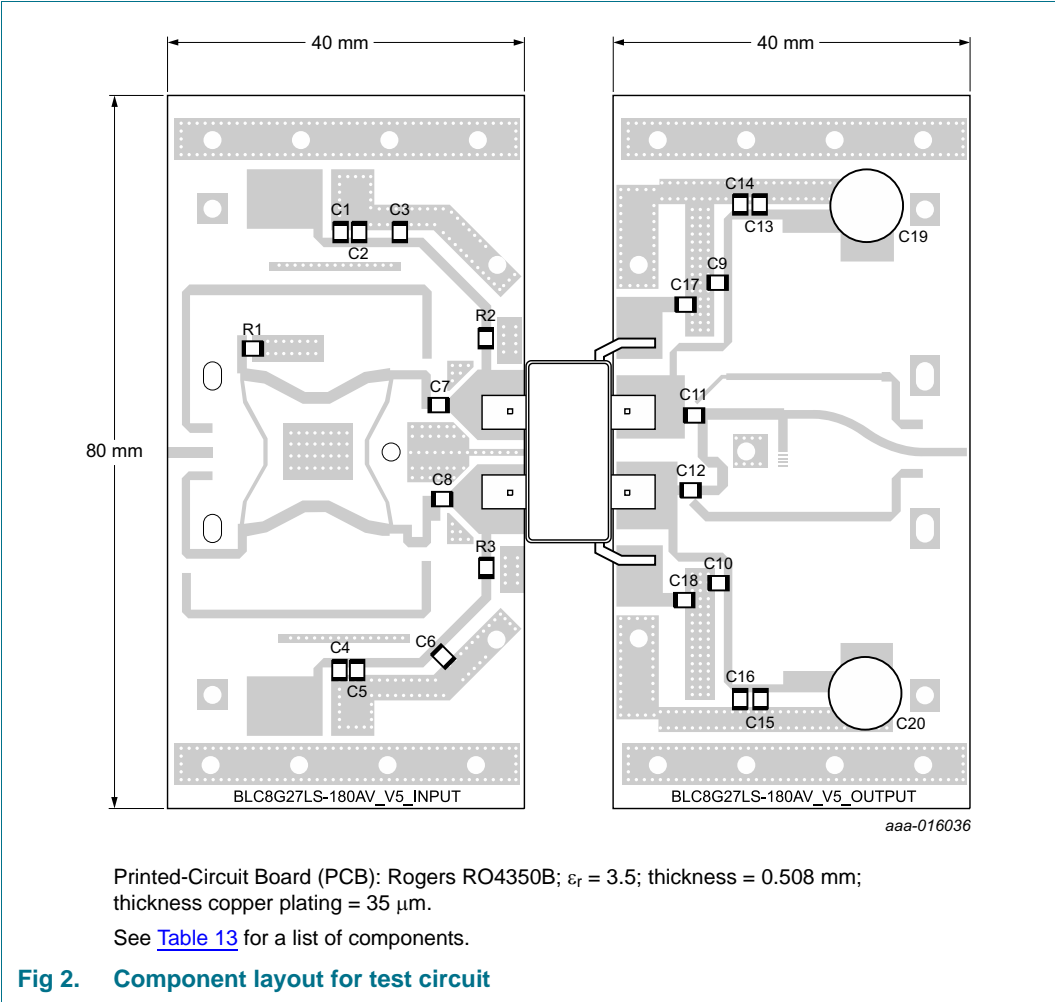
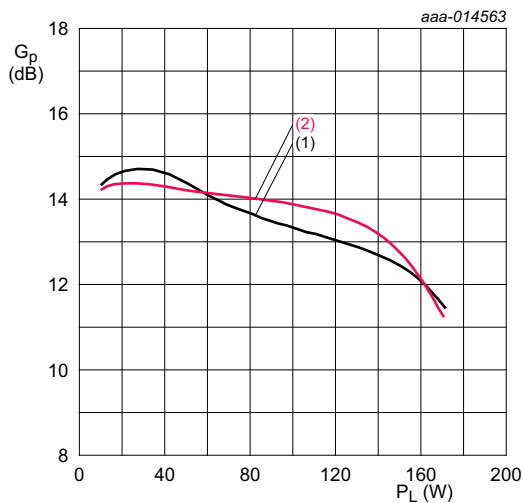


Table 13. List of components
See [Figure 2](#) for component layout.

Component	Description	Value	Remarks
C1, C4, C13, C15, C17, C18	multilayer ceramic chip capacitor	10 μF , 50 V	Murata: SMD 1206
C2, C5, C14, C16	multilayer ceramic chip capacitor	1 μF , 50 V	Murata: SMD 1206
C3, C6, C7, C8, C9, C10, C12	multilayer ceramic chip capacitor	11 pF	ATC 600F series
C11	multilayer ceramic chip capacitor	3 pF	ATC 600F series
C19, C20	electrolytic capacitor	2200 μF , 63 V	Vishay BCcomponents
R1	SMD resistor	50 Ω	
R2, R3	SMD resistor	5.1 Ω	SMD 0805

7.6 Graphical data

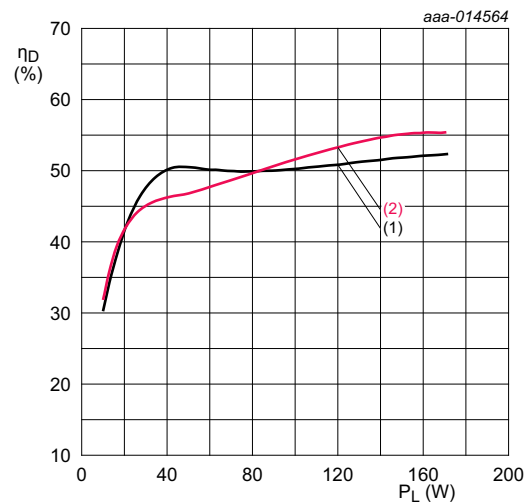
7.6.1 Pulsed CW



$V_{DS} = 28\text{ V}$; $I_{Dq} = 200\text{ mA}$ (main device);
 $V_{GS(amp)peak} = 0.6\text{ V}$; $t_p = 100\text{ }\mu\text{s}$; $\delta = 10\text{ }\%$.

(1) $f = 2496\text{ MHz}$
(2) $f = 2690\text{ MHz}$

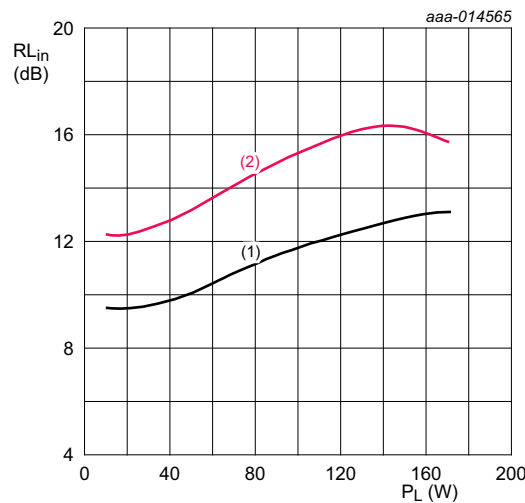
Fig 3. Power gain as a function of output power; typical values



$V_{DS} = 28\text{ V}$; $I_{Dq} = 200\text{ mA}$ (main device);
 $V_{GS(amp)peak} = 0.6\text{ V}$; $t_p = 100\text{ }\mu\text{s}$; $\delta = 10\text{ }\%$.

(1) $f = 2496\text{ MHz}$
(2) $f = 2690\text{ MHz}$

Fig 4. Drain efficiency as a function of output power; typical values

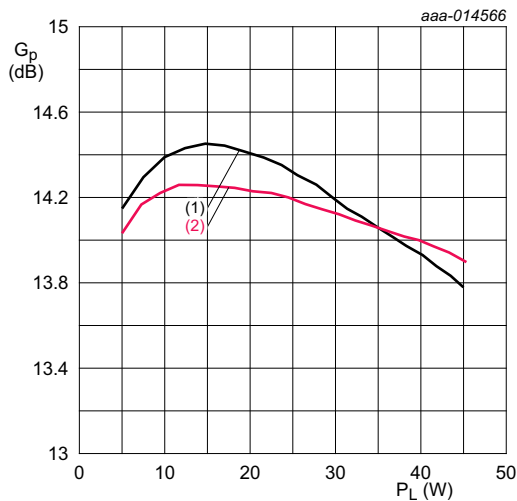


$V_{DS} = 28\text{ V}$; $I_{Dq} = 200\text{ mA}$ (main device); $V_{GS(amp)peak} = 0.6\text{ V}$; $t_p = 100\text{ }\mu\text{s}$; $\delta = 10\text{ }\%$.

(1) $f = 2496\text{ MHz}$
(2) $f = 2690\text{ MHz}$

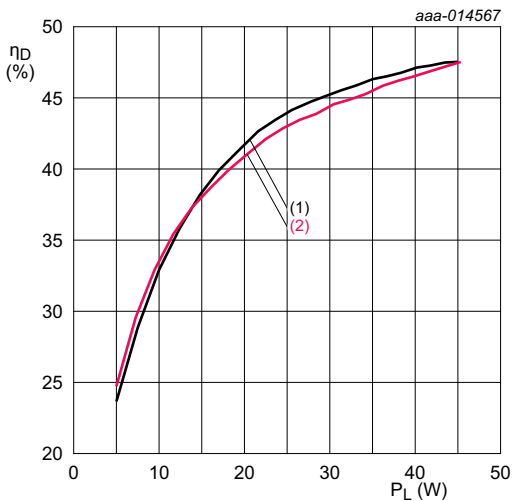
Fig 5. Input return loss as a function of output power; typical values

7.6.2 1-Carrier W-CDMA



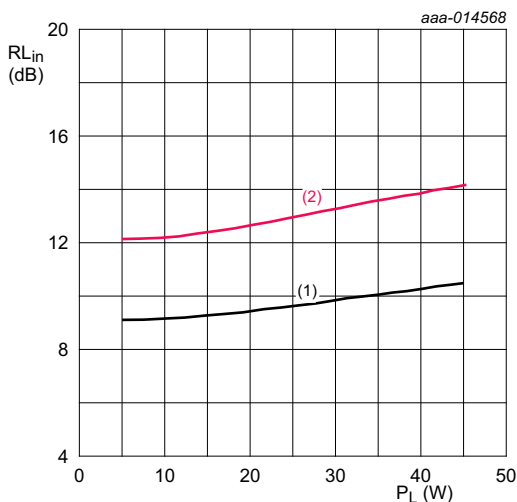
$V_{DS} = 28\text{ V}$; $I_{DQ} = 200\text{ mA}$ (main device);
 $V_{GS(amp)peak} = 0.6\text{ V}$.
(1) $f = 2496\text{ MHz}$
(2) $f = 2690\text{ MHz}$

Fig 6. Power gain as a function of output power; typical values



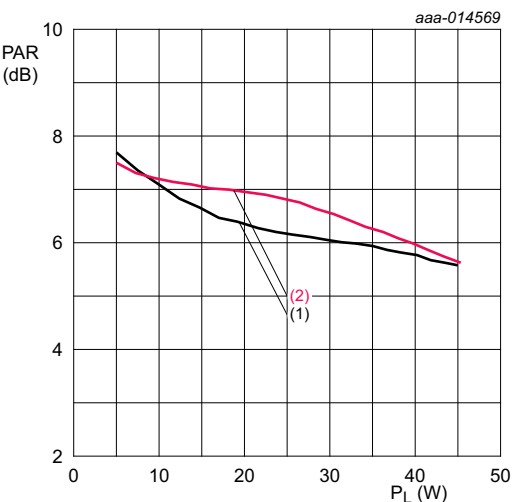
$V_{DS} = 28\text{ V}$; $I_{DQ} = 200\text{ mA}$ (main device);
 $V_{GS(amp)peak} = 0.6\text{ V}$.
(1) $f = 2496\text{ MHz}$
(2) $f = 2690\text{ MHz}$

Fig 7. Drain efficiency as a function of output power; typical values



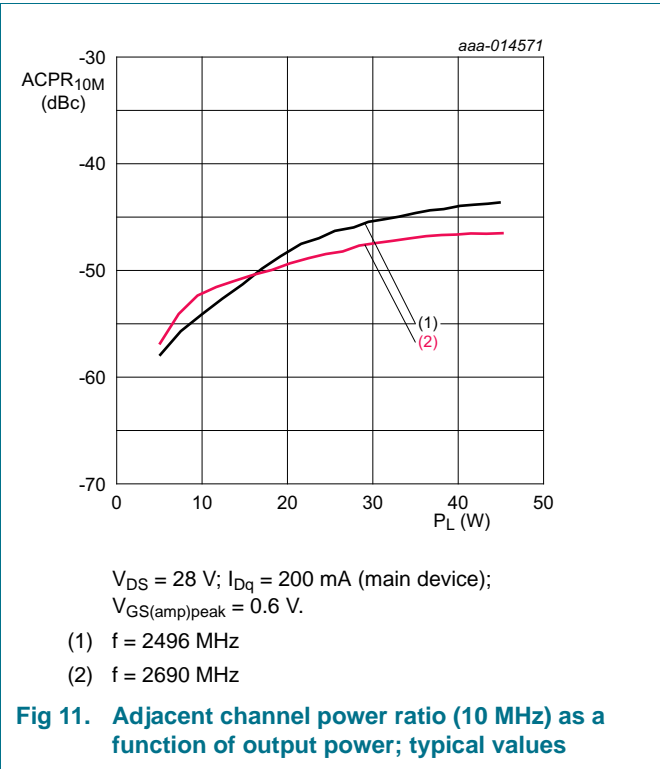
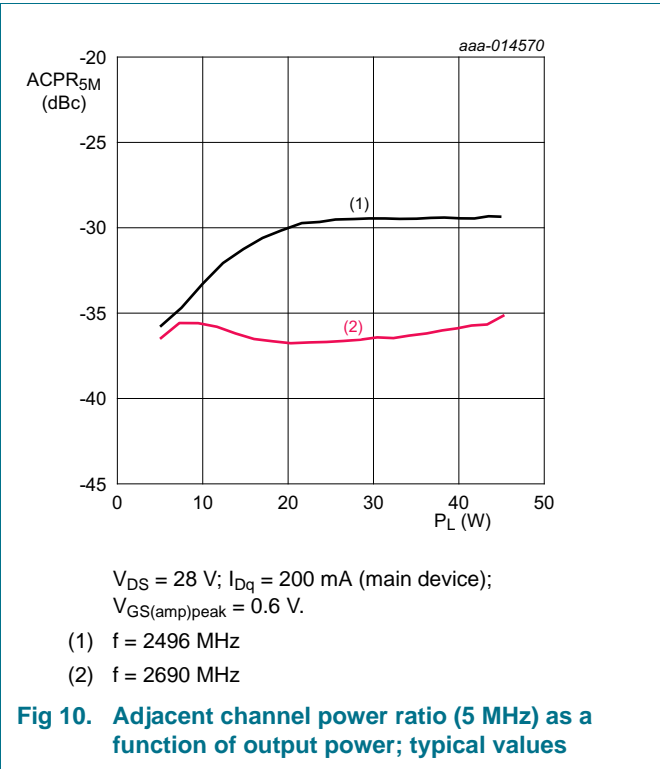
$V_{DS} = 28\text{ V}$; $I_{DQ} = 200\text{ mA}$ (main device);
 $V_{GS(amp)peak} = 0.6\text{ V}$.
(1) $f = 2496\text{ MHz}$
(2) $f = 2690\text{ MHz}$

Fig 8. Input return loss as a function of output power; typical values

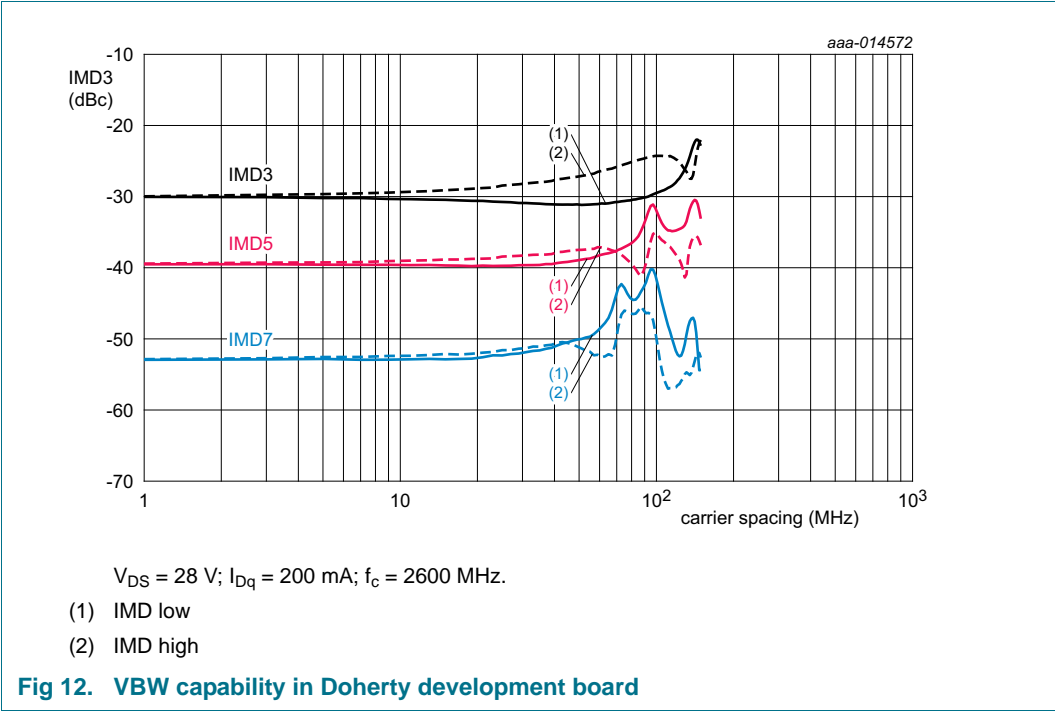


$V_{DS} = 28\text{ V}$; $I_{DQ} = 200\text{ mA}$ (main device);
 $V_{GS(amp)peak} = 0.6\text{ V}$.
(1) $f = 2496\text{ MHz}$
(2) $f = 2690\text{ MHz}$

Fig 9. Peak-to-average power ratio as a function of output power; typical values



7.6.3 2-Tone VBW



8. Package outline

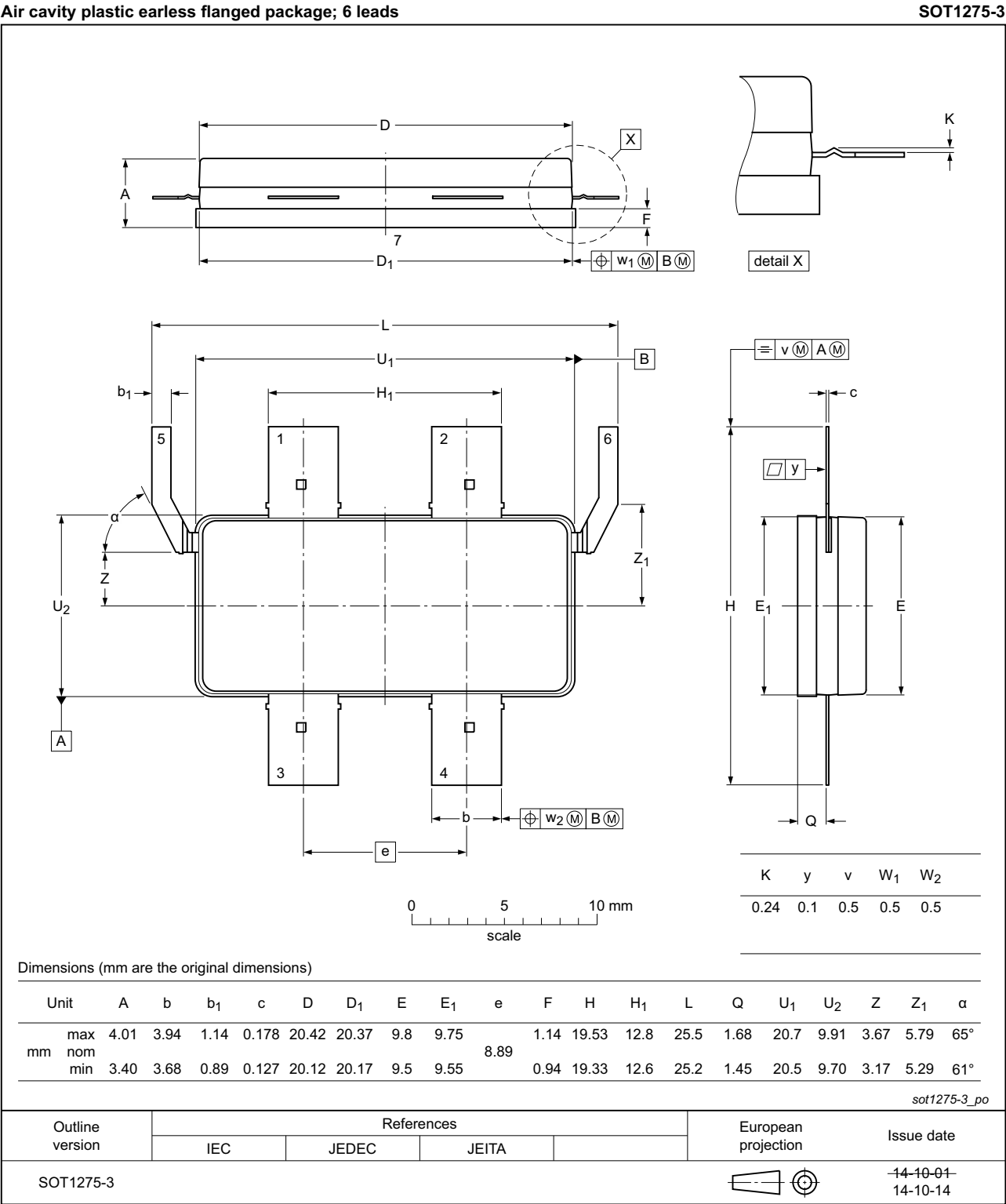


Fig 13. Package outline SOT1275-3

9. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

10. Abbreviations

Table 14. Abbreviations

Acronym	Description
3GPP	3rd Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
ESD	ElectroStatic Discharge
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
MTF	Median Time to Failure
PAR	Peak-to-Average Ratio
SMD	Surface-Mounted Device
VBW	Video BandWidth
VSWR	Voltage Standing-Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

11. Revision history

Table 15. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLC8G27LS-180AV v.2	20150209	Product data sheet	-	BLC8G27LS-180AV v.1
Modifications:	<ul style="list-style-type: none"> Table 1 on page 1: some changes have been made Section 1.2 on page 1: some changes have been made Table 2 on page 2: simplified outline drawing changed Table 3 on page 2: version changed from SOT1275-1 to SOT1275-3 Table 5 on page 2: some changes have been made Table 6 on page 3: table has been added Table 7 on page 3: table has been added Table 8 on page 3: table has been added Section 7 on page 4: section has been added Figure 13 on page 10: package outline changed from SOT1275-1 to SOT1275-3 			
BLC8G27LS-180AV v.1	20140701	Objective data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

12.4 Trademarks

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13. Contact information

For more information, please visit: <http://www.nxp.com>

For sales office addresses, please send an email to: salesaddresses@nxp.com

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Date of release: 9 February 2015

Document identifier: BLC8G27LS-180AV